Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/650,174	PARCE ET AL.	
Examiner	Art Unit	

1639

MY-CHAU T. TRAN

SEARCHED				
Class	Subclass	Date	Examiner	
435	6, 7.9, 287.1, 287.2, 288.3,	11/19/2005	мст	
435	288.4,	11/19/2005	мст	
435	288.7	11/19/2005	мст	
436	514, 518,	11/19/2005	мст	
436	527, 531,	11/19/2005	мст	
436	149, 150,	11/19/2005	мст	
436	151, 164,	11/19/2005	мст	
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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PALM Inventors; WEST - see printouT; STN - see printout.	11/19/2005	мст